

IAP2005070100 11 JAN 2006

PTO/SB/08a/b (07-05)


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Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Complete If Known 50/264092	
				Application Number	NEW
				Filing Date	January 11, 2006
				First Named Inventor	Yuhji ANDOH
				Art Unit	N/A
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	2936-0259PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
	AA*	US-6,008,482	12-28-1999	Takahashi et al.	
	AB*	US-5,934,178	08-10-1999	Caridis et al.	



FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ² -Number ³ -Kind Code ⁴ (# known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	BA	JP-54-127769-A	10-03-1979		
	BB	JP-8-178298-A	07-12-1996		
	BC	JP-2002-153380-A	05-28-2002		
	BD	JP-56-10202	01-28-1981		
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	BG	JP-9-4849-A	01-10-1997		
	BH	JP-54-59372-A	05-12-1979		
	BI	JP-10-290752-A	11-04-1998		

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